Tilted parallel dielectric slab as a multilevel attenuator for incident p- or s-polarized light

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Under the condition of first-order blooming, a parallel dielectric slab, which is inserted in the path of an obliquely incident \( p \)- or \( s \)-polarized light beam, introduces multiple discrete attenuation levels given by

\[
\begin{align*}
1 &= 3^1, \\
4 &= 3^2, \\
9 &= 3^3, \\
27 &= 3^3, \\
81 &= 3^4, \\
243 &= 3^5, \\
729 &= 3^6, \\
&\ldots
\end{align*}
\]

in reflection and

\[
\begin{align*}
4 &= 3^1, \\
9 &= 3^2, \\
81 &= 3^3, \\
243 &= 3^4, \\
729 &= 3^5, \\
&\ldots
\end{align*}
\]

in transmission. These attenuation levels are independent of the slab refractive index, incident \( p \) or \( s \) linear polarization, or the presence of identical transparent surface coatings at the front and back sides of the slab. Therefore, the tilted slab provides multidecade reflectance and attenuation reference values that can be used in calibrating spectrophotometers and filters, and also for testing the linearity of photodetectors. For an uncoated dielectric slab, incidence angles that cause first-order blooming are determined as functions of the slab refractive index for incident \( p \)- or \( s \)-polarized light. © 2009 Optical Society of America

1. Introduction

Optical attenuators that reduce the intensity of a light beam by a predetermined amount are useful for precise spectrophotometry [1], calibrating filters [2], testing the linearity of photodetectors [3–5], and in applications that involve high-power lasers [6–10]. Existing designs include the rotating-sector attenuator [1], a three-polarizer system that consists of two fixed outer polarizers and a rotating middle polarizer [2], variable-gap optical-tunneling (frustrated-total-internal-reflection) attenuator [6,7], wedged-plate attenuator [8], and reflective multimirror systems at oblique incidence [10].

In this paper an optically isotropic dielectric parallel slab (of zero-wedge angle) is shown to function as a multilevel attenuator for obliquely incident \( p \)- or \( s \)-polarized light, when the slab is oriented to achieve maximum first-order reflection. First-order blooming leads to a set of discrete attenuation levels that depend only on the number of internal reflections inside the slab but that are independent of the slab refractive index, incident \( p \) or \( s \) linear polarization, or the presence of identical transparent surface layers at the front and back sides of the slab. Tilted dielectric slabs are also key elements of division-of-amplitude photopolarimeters that are used for partial or complete measurement of the state of polarization of light [11–13].

In Section 2 the principle of operation of the multilevel parallel-dielectric-slab attenuator under the first-order blooming condition is considered. The analysis of Section 2 is independent of the selected \( p \) or \( s \) linear polarization, slab refractive index, or the presence of identical surface layers at the front and back of the slab. In Sections 3 and 4 uncoated-dielectric-slab attenuators for incident \( s \) and \( p \) linearly polarized light are considered separately, and the corresponding incidence angles that lead to first-order blooming are obtained as functions of the slab refractive index. Section 5 gives a brief summary of the results presented in this paper.

2. Principle of Operation

Figure 1 shows the reflection and transmission (in air) of a light beam by a homogeneous and optically isotropic dielectric slab of refractive index \( n \) and uniform thickness \( d \) at an angle of incidence \( \phi \). (The slab thickness \( d \) is chosen sufficiently large compared to...
the beam diameter to prevent overlapping of the parallel beams that exit the slab from either side.) If unit-intensity $p$- or $s$-polarized incident light is assumed, the intensity $I_m$ of the $p$- or $s$-polarized beam that exits the slab after $m$ internal reflections is given by

$$I_m = R_v^m(1 - R_v)^2, \quad \nu = p, s, \quad m \geq 1. \quad (1)$$

In Eq. (1) $R_v$ is the zeroth-order intensity reflectance of the air-slab interface for the $\nu$ polarization. Odd order numbers ($m = 1, 3, 5, \ldots$) correspond to the reflected beams and even order numbers ($m = 2, 4, 6, \ldots$) represent the transmitted ones. Substitution of $m = 0$ in Eq. (1) gives the intensity of the zeroth-order transmitted beam.

Figure 2 shows the intensity $I_m$ of the $m$th-order beam plotted as a function of front-surface reflectance $R_v$ for different values of the order number $m$. ($\nu = p, s$ represent the linear polarizations parallel and perpendicular to the plane of incidence, respectively.) Continuous and dashed lines correspond to the reflected and transmitted orders, respectively.

front-surface reflectance $R_v$ is adjusted (by tilting the slab) to take the specific value given by Eq. (3).

For the attenuator application 1st-order blooming is of particular interest. Under this condition, the slab (which is inserted in the path of incident $p$- or $s$-polarized light beam) introduces the following discrete attenuation levels: $1/3, 4/27, 4/243, \ldots$, in reflection and $4/9, 4/81, 4/729, \ldots$, in transmission. Again, it is important to emphasize that these discrete attenuation levels are the same regardless of the slab refractive index $n$, incident $p$ or $s$ linear polarization, or the presence of identical transparent surface coatings at the front and back sides of the slab.

Another interesting consequence of first-order blooming is that the sum of intensities of all reflected orders is the same as the sum of intensities of all transmitted orders and equals 1/2 when the slab is presumed lossless.

3. Uncoated-Parallel-Slab Attenuator for Incident $s$-Polarized Light

The Fresnel amplitude reflection coefficient for $s$-polarized light which is incident from air on an uncoated dielectric slab of refractive index $n$ at an angle of incidence $\phi$ is given by

$$r_s = \frac{\cos \phi - (n^2 - \sin^2 \phi)^{1/2}}{\cos \phi + (n^2 - \sin^2 \phi)^{1/2}}. \quad (5)$$

Equation (5) can be solved for $n^2$:

$$n^2 = \sin^2 \phi + (1 - \sin^2 \phi)\left(1 - r_s r_s^{1/2}\right). \quad (6)$$
First-order blooming occurs when \( R_s = 1/3 \), hence \( r_s = -1/\sqrt{3} \), where the minus sign is consistent with the Nebraska–Müller conventions [14,15]. Substitution of \( r_s = -1/\sqrt{3} \) in Eq. (6) and solving for \( \sin^2 \phi_s = \phi_s \), we obtain

\[
\sin^2 \phi_s = \frac{(7 + 4\sqrt{3}) - n^2}{(6 + 4\sqrt{3})}.
\] (7)

Equation (7) indicates that the slab refractive index \( n \) must be limited to the range

\[
n \leq 2 + \sqrt{3}.
\] (8)

Most optical materials that are transparent in the visible and IR spectrum have refractive indices [16] that satisfy Eq. (8). For example, for a glass slab with \( n = 1.5 \), Eq. (5) predicts first-order blooming at \( \phi_s = 78.772^\circ \). This predicts experimental by reflecting an s-polarized, 633 nm, He–Ne laser beam by a 10 mm thick polished optical glass parallel plate and rotating the slab until first-order blooming is achieved. The incidence angle measured by a precision (0.005°) goniometer agreed with the theoretical result to within 0.1°. Further improvement in the precise determination of the angular position of maximum first-order reflection can be achieved by superimposing a small (e.g., 0.5°) torsional oscillation and using a lock-in amplifier to zero the first harmonic of the detector signal at the modulation frequency.

4. Uncoated-Parallel-Slab Attenuator for Incident \( p \)-Polarized Light

For incident \( p \)-polarized light, first-order blooming occurs below the Brewster angle \( (\phi_p = \tan^{-1} n) \) when the amplitude reflectance at the air-slab interface \( r_p = +1/\sqrt{3} \). By substituting \( r_p = +1/\sqrt{3} \) in the Fresnel amplitude reflection coefficient for the \( p \) polarization,

\[
r_p = \frac{n^2 \cos \phi - (n^2 - \sin^2 \phi)^{1/2}}{n^2 \cos \phi + (n^2 - \sin^2 \phi)^{1/2}},
\] (9)

the incidence angle \( \phi = \phi_p \) of first-order blooming is obtained,

\[
\sin^2 \phi_p = \left( \frac{n^2 |n^2 - (7 - 4\sqrt{3})|}{|n^4 - (7 - 4\sqrt{3})|} \right), \quad n \geq 2 + \sqrt{3}.
\] (10)

For an uncoated Ge slab \( (n = 4) \), Eq. (7) gives \( \phi_p = 21.719^\circ \). Because of its weak dispersion, a multireflection Ge slab is a suitable candidate as an attenuator for incident \( p \)-polarized light over a broad IR spectral range [16].

First-order blooming of \( p \)-polarized light can also take place above the Brewster angle when \( r_p = -1/\sqrt{3} \). (Note that the plus and minus signs, or the 0 or \( \pi \) reflection phase shifts, are consistent with the Nebraska–Müller conventions [14,15].) By substitution of \( r_p = -1/\sqrt{3} \) in Eq. (9), we obtain the corresponding angle of incidence, \( \phi = \phi_p \), of first-order blooming:

\[
\sin^2 \phi_p = \left( \frac{n^2 |n^2 - (7 + 4\sqrt{3})|}{|n^4 - (7 + 4\sqrt{3})|} \right), \quad n \leq 2 + \sqrt{3}.
\] (11)

For a glass slab with \( n = 1.5 \), one obtains \( \phi_p = 82.293^\circ \) from Eq. (11). Based on Eq. (11) the minimum incidence angle for first-order blooming of \( p \)-polarized light above the Brewster angle is \( \phi_p = 82.229^\circ \), which corresponds to \( n = 1.401226 \). Such high angles are obviously unsuitable and render \( p \)-polarization attenuators that use low-index slabs impractical.

If both sides of a low-index (e.g., glass) slab are coated with a quarter-wave-thick high-index (e.g., TiO\textsubscript{2}) film, first-order blooming of \( p \)- or \( s \)-polarized light becomes possible at lower angles of incidence [17].

5. Summary

The use of a tilted parallel dielectric slab as a multilevel attenuator for incident \( p \)- or \( s \)-polarized light has been described. Multidecade discrete attenuation levels are attained under the condition of first-order blooming. These levels are independent of the slab refractive index, incident \( p \) or \( s \) linear polarization, or the presence of identical transparent surface coatings at the front and back sides of the slab. Potential applications of these simple attenuators include calibration of spectrophotometers and filters and testing the linearity of photodetectors. For use of the device as a possible attenuation or reflectance standard the effect of residual absorption, surface roughness, surface flatness, small wedge angle, temperature, stress-induced birefringence, and spectral bandwidth should be considered.

References